Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/905,341	YANN ET AL.
Examiner	Art Unit
Minh Dieu Nguyen	2137

Subclass	Date	Examiner
189, 201	7/44/0005	
	7/11/2005	MDN
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB)	7/11/2005	MDN
Updated search on EAST (US-PAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB)	7/11/2005	MDN
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